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**FDMS86520L** 

#### October 2014

## N-Channel PowerTrench<sup>®</sup> MOSFET 60 V, 22 A, 8.2 m $\Omega$

#### **Features**

- Max  $r_{DS(on)} = 8.2 \text{ m}\Omega$  at  $V_{GS} = 10 \text{ V}$ ,  $I_D = 13.5 \text{ A}$
- Max  $r_{DS(on)} = 11.7 \text{ m}\Omega$  at  $V_{GS} = 4.5 \text{ V}$ ,  $I_D = 11.5 \text{ A}$
- Advanced package and silicon combination for low r<sub>DS(on)</sub> and high efficiency
- MSL1 robust package design
- 100% UIL tested
- RoHS Compliant

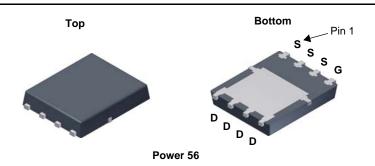


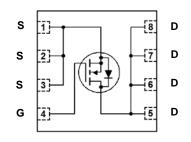
#### **General Description**

This N-Channel MOSFET has been designed specifically to improve the overall efficiency and to minimize switch node ringing of DC/DC converters using either synchronous or conventional switching PWM controllers. It has been optimized for low gate charge, low  $r_{DS(on)}$ , fast switching speed and body diode reverse recovery performance.

### **Applications**

- Primary Switch in isolated DC-DC
- Synchronous Rectifier
- Load Switch





#### MOSFET Maximum Ratings T<sub>A</sub> = 25 °C unless otherwise noted

| Symbol                            | Paramet                                  | Ratings                | Units     |             |    |
|-----------------------------------|--|------------------------|-----------|-------------|----|
| V <sub>DS</sub>                   | Drain to Source Voltage                  |                        |           | 60          | V  |
| $V_{GS}$                          | Gate to Source Voltage                   |                        |           | ±20         | V  |
| I <sub>D</sub>                    | Drain Current -Continuous                | T <sub>C</sub> = 25 °C |           | 22          |    |
|                                   | -Continuous                              | T <sub>A</sub> = 25 °C | (Note 1a) | 13.5        | Α  |
|                                   | -Pulsed                                  |                        |           | 60          |    |
| E <sub>AS</sub>                   | Single Pulse Avalanche Energy            |                        | (Note 3)  | 91          | mJ |
| P <sub>D</sub>                    | Power Dissipation                        | T <sub>C</sub> = 25 °C |           | 69          | w  |
|                                   | Power Dissipation                        | T <sub>A</sub> = 25 °C | (Note 1a) | 2.5         | VV |
| T <sub>J</sub> , T <sub>STG</sub> | Operating and Storage Junction Temperatu | ıre Range              |           | -55 to +150 | °C |

#### **Thermal Characteristics**

| $R_{\theta JC}$ | Thermal Resistance, Junction to Case             | 1.8 | °C/W |
|-----------------|--|-----|------|
| $R_{\theta JA}$ | Thermal Resistance, Junction to Ambient (Note 1a | 50  | C/VV |

#### **Package Marking and Ordering Information**

| Device Marking | Device     | Package  | Reel Size | Tape Width | Quantity   |
|----------------|------------|----------|-----------|------------|------------|
| FDMS86520L     | FDMS86520L | Power 56 | 13 "      | 12 mm      | 3000 units |

## **Electrical Characteristics** $T_J = 25$ °C unless otherwise noted Parameter

| Off Chai                               | racteristics                                 |   |    |    |      |       |
|--|--|---|----|----|------|-------|
| $BV_DSS$                               | Drain to Source Breakdown Voltage            | $I_D = 250 \mu A, V_{GS} = 0 V$                   | 60 |    |      | V     |
| $\frac{\Delta BV_{DSS}}{\Delta T_{J}}$ | Breakdown Voltage Temperature<br>Coefficient | $I_D$ = 250 $\mu$ A, referenced to 25 °C          |    | 29 |      | mV/°C |
| I <sub>DSS</sub>                       | Zero Gate Voltage Drain Current              | V <sub>DS</sub> = 48 V, V <sub>GS</sub> = 0 V     |    |    | 1    | μΑ    |
| I <sub>GSS</sub>                       | Gate to Source Leakage Current               | $V_{GS} = \pm 20 \text{ V}, V_{DS} = 0 \text{ V}$ |    |    | ±100 | nA    |

**Test Conditions** 

Min

Тур

Max

Units

#### **On Characteristics**

Symbol

| $V_{GS(th)}$                           | Gate to Source Threshold Voltage                            | $V_{GS} = V_{DS}, I_D = 250 \mu A$   | 1 | 1.8 | 3    | V     |
|--|---|--|---|-----|------|-------|
| $\frac{\Delta V_{GS(th)}}{\Delta T_J}$ | Gate to Source Threshold Voltage<br>Temperature Coefficient | $I_D$ = 250 $\mu$ A, referenced to 25 °C                                       |   | -7  |      | mV/°C |
| r <sub>DS(on)</sub> Static D           | Static Drain to Source On Resistance                        | V <sub>GS</sub> = 10 V, I <sub>D</sub> = 13.5 A                                |   | 6.7 | 8.2  | mΩ    |
|  |   | $V_{GS} = 4.5 \text{ V}, I_D = 11.5 \text{ A}$                                 |   | 9.1 | 11.7 |       |
|  | Static Drain to Source On Nesistance                        | $V_{GS} = 10 \text{ V}, I_D = 13.5 \text{ A},$<br>$T_J = 125 ^{\circ}\text{C}$ |   | 9.6 | 11.8 |       |
| g <sub>FS</sub>                        | Forward Transconductance                                    | V <sub>DS</sub> = 5 V, I <sub>D</sub> = 13.5 A                                 |   | 51  |      | S     |

#### **Dynamic Characteristics**

| C <sub>iss</sub> | Input Capacitance            | V 20 V V 0 V   | 3470 | 4615 | pF |
|------------------|------------------------------|--|------|------|----|
| C <sub>oss</sub> | Output Capacitance           | $V_{DS} = 30 \text{ V}, V_{GS} = 0 \text{ V},$<br>f = 1  MHz | 625  | 835  | pF |
| C <sub>rss</sub> | Reverse Transfer Capacitance | 1 - 1 1/11/12  | 25   | 45   | pF |
| $R_g$            | Gate Resistance              |  | 0.6  |      | Ω  |

#### **Switching Characteristics**

| t <sub>d(on)</sub>  | Turn-On Delay Time            |   | 15  | 27 | ns |
|---------------------|-------------------------------|---|-----|----|----|
| t <sub>r</sub>      | Rise Time                     | $V_{DD} = 30 \text{ V, } I_{D} = 13.5 \text{ A,}$   | 5.6 | 11 | ns |
| t <sub>d(off)</sub> | Turn-Off Delay Time           | $V_{GS}$ = 10 V, $R_{GEN}$ = 6 $\Omega$             | 32  | 52 | ns |
| t <sub>f</sub>      | Fall Time                     |   | 3.4 | 10 | ns |
| Qg                  | Total Gate Charge             | V <sub>GS</sub> = 0 V to 10 V                       | 45  | 63 | nC |
| Qg                  | Total Gate Charge             | $V_{GS} = 0 \ V \text{ to } 4.5 \ V_{DD} = 30 \ V,$ | 21  | 30 | nC |
| Q <sub>gs</sub>     | Gate to Source Charge         | I <sub>D</sub> = 13.5 A                             | 9.5 |    | nC |
| $Q_{gd}$            | Gate to Drain "Miller" Charge |   | 4.7 |    | nC |

#### **Drain-Source Diode Characteristics**

| V <sub>SD</sub> | Source-Drain Diode Forward Voltage | $V_{GS} = 0 \text{ V}, I_S = 2.1 \text{ A}$ (Note 2)    | 0.72 | 1.2 | \/ |
|-----------------|------------------------------------|---|------|-----|----|
|                 | Source-Drain Diode Forward Voltage | V <sub>GS</sub> = 0 V, I <sub>S</sub> = 13.5 A (Note 2) | 0.83 | 1.3 | v  |
| t <sub>rr</sub> | Reverse Recovery Time              | I <sub>E</sub> = 13.5 A, di/dt = 100 A/μs               | 37   | 60  | ns |
| Q <sub>rr</sub> | Reverse Recovery Charge            | I <sub>F</sub> = 13.3 A, α/αι = 100 A/μs                | 21   | 34  | nC |
| t <sub>rr</sub> | Reverse Recovery Time              | I <sub>E</sub> = 13.5 A, di/dt = 300 A/μs               | 30   | 48  | ns |
| Q <sub>rr</sub> | Reverse Recovery Charge            | i <sub>F</sub> = 13.5 A, αι/αι = 300 A/μs               | 37   | 59  | nC |

<sup>1.</sup>  $R_{\theta JA}$  is determined with the device mounted on a 1 in<sup>2</sup> pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material.  $R_{\theta JC}$  is guaranteed by design while  $R_{\theta CA}$  is determined by the user's board design.



a. 50 °C/W when mounted on a 1 in<sup>2</sup> pad of 2 oz copper.



b. 125 °C/W when mounted on a minimum pad of 2 oz copper.

<sup>2.</sup> Pulse Test: Pulse Width < 300  $\mu\text{s},$  Duty cycle < 2.0%.

<sup>3.</sup> Starting  $T_J$  = 25 °C, L = 1 mH,  $I_{AS}$  = 13.5 A,  $V_{DD}$  = 54 V,  $V_{GS}$  = 10 V. 100% test at L = 0.1 mH,  $I_{AS}$  = 29 A.

## Typical Characteristics $T_J = 25$ °C unless otherwise noted

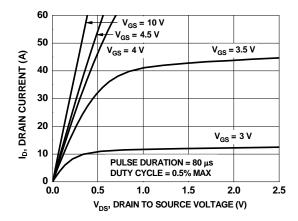


Figure 1. On Region Characteristics

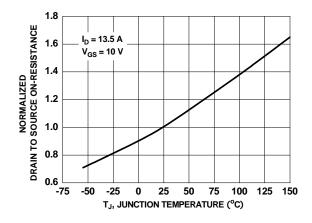


Figure 3. Normalized On Resistance vs Junction Temperature

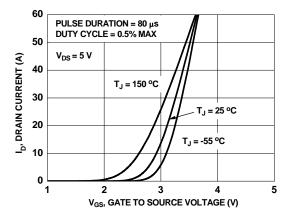


Figure 5. Transfer Characteristics

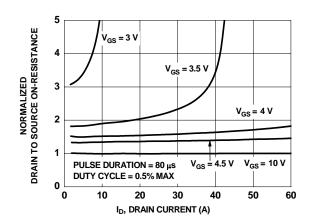


Figure 2. Normalized On-Resistance vs Drain Current and Gate Voltage

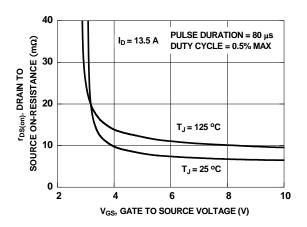


Figure 4. On-Resistance vs Gate to Source Voltage

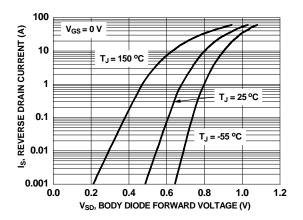


Figure 6. Source to Drain Diode Forward Voltage vs Source Current

## **Typical Characteristics** $T_J = 25$ °C unless otherwise noted

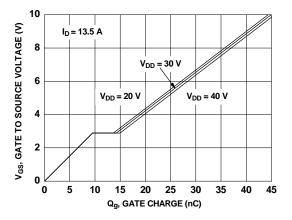


Figure 7. Gate Charge Characteristics

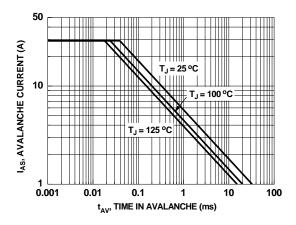


Figure 9. Unclamped Inductive Switching Capability

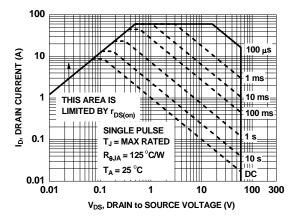


Figure 11. Forward Bias Safe Operating Area

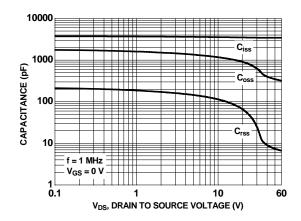


Figure 8. Capacitance vs Drain to Source Voltage

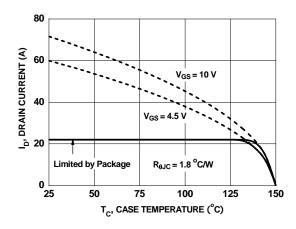


Figure 10. Maximum Continuous Drain Current vs Case Temperature

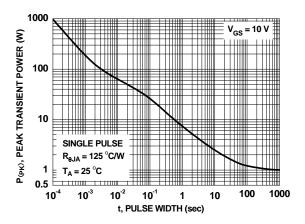


Figure 12. Single Pulse Maximum Power Dissipation

## **Typical Characteristics** $T_J = 25$ °C unless otherwise noted

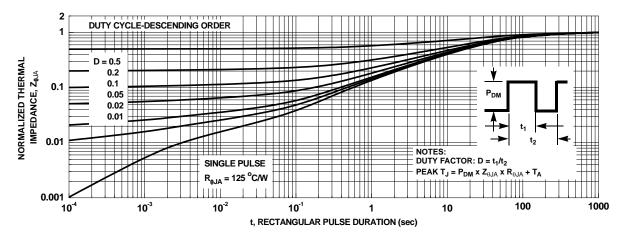


Figure 13. Junction-to-Ambient Transient Thermal Response Curve



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